Preferred Device

Sensitive Gate Silicon Controlled Rectifiers

Reverse Blocking Thyristors

Designed for industrial and consumer applications such as temperature, light and speed control; process and remote controls; warning systems; capacitive discharge circuits and MPU interface.

Features

- Center Gate Geometry for Uniform Current Density
- All Diffused and Glass-Passivated Junctions for Parameter Uniformity and Stability
- Small, Rugged Thermowatt Construction for Low Thermal Resistance, High Heat Dissipation and Durability
- Low Trigger Currents, 200 μA Maximum for Direct Driving from Integrated Circuits
- Pb-Free Packages are Available*

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
$\begin{tabular}{lll} Peak Repetitive Off-State Voltage (Note 1) \\ (T_J = -40 to 110 ^{\circ}C, Sine Wave, \\ 50 to 60 Hz, Gate Open) & MCR72-3 \\ & MCR72-6 \\ & MCR72-8 \\ \end{tabular}$	V _{DRM} , V _{RRM}	100 400 600	V
On-State RMS Current (180° Conduction Angles; T _C = 83°C)	I _{T(RMS)}	8.0	Α
Peak Non-Repetitive Surge Current (1/2 Cycle, 60 Hz, T _J = 110°C)	I _{TSM}	100	Α
Circuit Fusing Considerations (t = 8.3 ms)	l ² t	40	A ² s
Forward Peak Gate Voltage (t ≤ 10 μs, T _C = 83°C)	V_{GM}	±5.0	V
Forward Peak Gate Current (t \leq 10 μ s, T _C = 83°C)	I _{GM}	1.0	Α
Forward Peak Gate Power (t \leq 10 μ s, T _C = 83°C)	P _{GM}	5.0	W
Average Gate Power (t = 8.3 ms, T _C = 83°C)	P _{G(AV)}	0.75	W
Operating Junction Temperature Range	TJ	-40 to +110	°C
Storage Temperature Range	T _{stg}	-40 to +150	°C
Mounting Torque	_	8.0	in. lb.

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

 V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

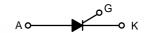
*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

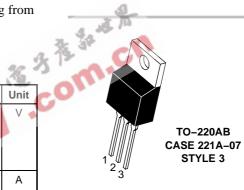


ON Semiconductor®

http://onsemi.com

SCRs 8 AMPERES RMS 100 thru 600 VOLTS





TO-220AB CASE 221A-09 STYLE 3



PIN ASSIGNMENT				
1	Cathode			
2	Anode			
3	Gate			
4	Anode			

MARKING AND ORDERING INFORMATION

See detailed marking, ordering, and shipping information in the package dimensions section on page 4 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	2.2	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{ heta JA}$	60	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Secs	TL	260	°C

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted.)

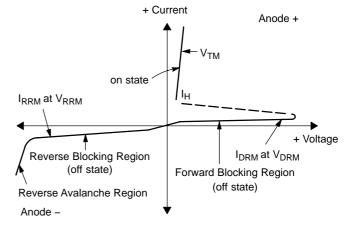
Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				
Peak Repetitive Forward or Reverse Blocking Current (Note 2) $ (V_{AK} = Rated \ V_{DRM} \ or \ V_{RRM}; \ R_{GK} = 1 \ k\Omega) $		- -	- -	10 500	μ Α μ Α
High Logic Level Supply Current from V _{CC}	Іссн	4	4	μΑ	μΑ
ON CHARACTERISTICS	·				
Peak Forward On-State Voltage (I _{TM} = 16 A Peak, Pulse Width ≤ 1 ms, Duty Cycle ≤ 2%)	V _{TM}	_	1.7	2.0	V
Gate Trigger Current (Continuous dc) (Note 3) (V _D = 12 V, R _L = 100 Ω)	I _{GT}	-	30	200	μΑ
Gate Trigger Voltage (Continuous dc) (Note 3) (V _D = 12 V, R _L = 100 Ω)	V _{GT}	-	0.5	1.5	V
Gate Non–Trigger Voltage $(V_D = 12 \text{ Vdc}, R_L = 100 \Omega, T_J = 110^{\circ}\text{C})$	V_{GD}	0.1	-	-	V
Holding Current (V _D = 12 V, Initiating Current = 200 mA, Gate Open)	l _H	-	-	6.0	mA
Gate Controlled Turn-On Time $(V_D = Rated V_{DRM}, I_{TM} = 16 A, I_G = 2 mA)$	t _{gt}	_	1.0	_	μs
OYNAMIC CHARACTERISTICS				•	
Critical Rate-of-Rise of Off-State Voltage ($V_D = Rated \ V_{DRM}, \ R_{GK} = 1 \ k\Omega, \ T_J = 110^{\circ}C, \ Exponential \ Waveform)$	dv/dt	_	10	_	V/μs

^{2.} Ratings apply for negative gate voltage or R_{GK} = 1 kΩ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.

^{3.} R_{GK} current not included in measurement.

Voltage Current Characteristic of SCR

Symbol	Parameter
V_{DRM}	Peak Repetitive Off State Forward Voltage
I _{DRM}	Peak Forward Blocking Current
V _{RRM}	Peak Repetitive Off State Reverse Voltage
I _{RRM}	Peak Reverse Blocking Current
V_{TM}	Peak On State Voltage
I _H	Holding Current



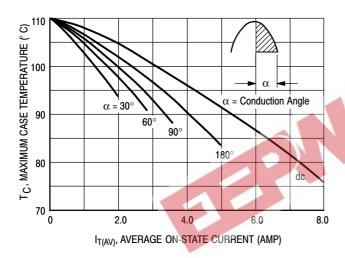


Figure 1. Average Current Derating

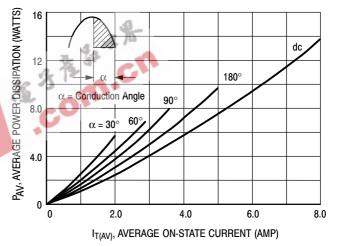


Figure 2. On-State Power Dissipation

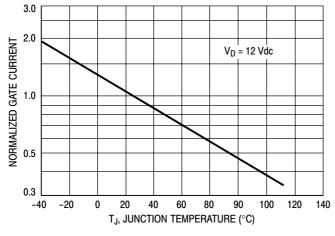


Figure 3. Normalized Gate Current

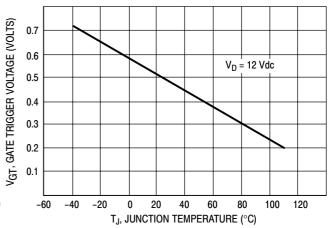
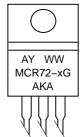


Figure 4. Gate Voltage

MARKING DIAGRAMS

TO-220AB CASE 221A-07



TO-220AB CASE 221A-09



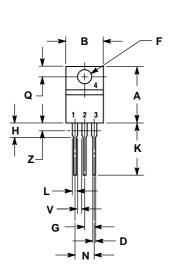
ORDERING INFORMATION

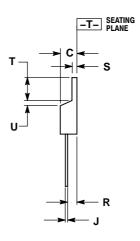
A = Assembly Y = Year WW = Work We MCR72-x = Device C x = 3, 6, G = Pb-Free AKA = Diode Pc	Y eek	= Assembly Location = Year = Work Week -6T = Device Code = Pb-Free Package = Diode Polarity	
Device	Package •	Shipping	
MCR72-3	TO-220AB		
MCR72-3G	TO-220AB (Pb-Free)	500 H % (D	
MCR72-6	TO-220AB	500 Units / Box	
MCR72-6G	TO-220AB (Pb-Free)		
MCR72-6T	TO-220AB		
MCR72-6TG	TO-220AB (Pb-Free)	50 Units / Rail	
MCR72-8	TO-220AB		
MCR72-8G	TO-220AB (Pb-Free)	500 Units / Box	
MCR72-8T	TO-220AB		
MCR72-8TG	TO-220AB (Pb-Free)	50 Units / Rail	

PACKAGE DIMENSIONS

TO-220AB

CASE 221A-07 **ISSUE AA**

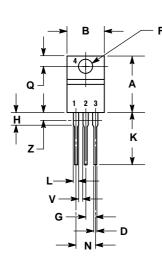


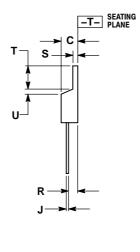


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

		INC	HES	MILLIN	IETERS
	DIM	MIN	MAX	MIN	MAX
	Α	0.570	0.620	14.48	15.75
	В	0.380	0.405	9.66	10.28
	С	0.160	0.190	4.07	4.82
	D	0.025	0.035	0.64	0.88
	F	0.142	0.147	3.61	3.73
	G	0.095	0.105	2.42	2.66
	Н	0.110	0.155	2.80	3.93
	J	0.014	0.022	0.36	0.55
	K	0.500	0.562	12.70	14.27
	L	0.045	0.060	1.15	1.52
− R	N	0.190	0.210	4.83	5.33
	Q	0.100	0.120	2.54	3.04
J	R	0.080	0.110	2.04	2.79
	S	0.045	0.055	1.15	1.39
the state of the s	T	0.235	0.255	5.97	6.47
	U	0.000	0.050	0.00	1.27
	V	0.045		1.15	
7c 3r	Z		0.080		2.04
12. 19	C.	100			
00 25	STYLE				
26	PIN		HODE		
132		2. ANO			
~0"		3. GATI	_		
		4. ANO	DE		
_					

- TO-220AB CASE 221A-09 ISSUE AA





NOTES:

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G	0.095	0.105	2.42	2.66	
Н	0.110	0.155	2.80	3.93	
J	0.018	0.025	0.46	0.64	
K	0.500	0.562	12.70	14.27	
L	0.045	0.060	1.15	1.52	
N	0.190	0.210	4.83	5.33	
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U	0.000	0.050	0.00	1.27	
٧	0.045		1.15		
Z		0.080		2.04	

- STYLE 3: PIN 1. CATHODE
 - 2. ANODE 3. GATE 4. ANODE



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